

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,736	YUAN ET AL.	
Examiner	Art Unit	
Chau Nguyen	2176	

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					
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SEARCH NO (INCLUDING SEARCH	TES H STRATEGY)
	DATE	EXMR
Updated Search on East Reports	11/6/2007	CN
	11/7/2007	CN
	11/8/2007	CN